

## GPI65010DF88

N-channel 650V10A GaN Power HEMT in 8X8 DFN package

**Datasheet version: 2.2 Preliminary** 

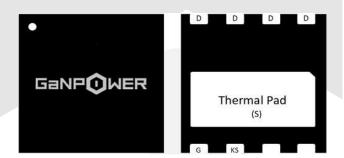
#### **Features**

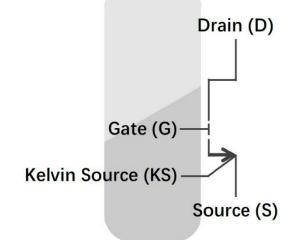
BV <sub>dss</sub>	R <sub>dson</sub>	l <sub>ds</sub>	$Q_{g}$
650 V	120 mΩ	10 A	2.6 nC

- Ultra-low Rps(on)
- High dv/dt capability
- Extremely low input capacitance
- Zero Qrr
- Outstanding switching performance
- Low Profile

#### **Applications**

- Switching Power Applications
- Adapters, Quick Chargers





#### **Description**

These devices are N-channel 650 V Power GaN HEMTs based on proprietary E-mode GaN on silicon technology. The resulting product has extremely low on state resistance, very low input capacitance and zero reverse recovery charge making it especially suitable for applications which require superior power density, ultra-high switching frequency and outstanding efficiency.



### **Device Characteristics**

Static Parameters			Test data				
	Parameters		Conditions	Min	Typical	Max	Unit
1	$V_{gs(TH)}$	Gate threshold voltage	V <sub>ds</sub> =V <sub>gs</sub> Id=3.5mA	1.0	1.4	1.7	V
2	BV <sub>dss</sub>	Drain-Source breakdown voltage	V <sub>gs</sub> =0V I <sub>d</sub> =25uA		650		V
3	l <sub>dss</sub>	Zero gate voltage drain current, $T_C$ = 25 $C^{\circ}$	V <sub>gs</sub> =0V V <sub>ds</sub> =650V		0.8	25	uA
4	$I_{gss}$	Gate-Source Leakage	$V_{gs} = 6V$ $V_{ds} = 0V$		50	100	uA
5	R <sub>dson</sub>	Static drain-source on resistance, $T_C = 25C^{\circ}$	V <sub>gs</sub> =6V I <sub>d</sub> =2.5A		120		mΩ
6	$V_{sd}$	Reverse conduction voltage	I <sub>sd</sub> =1A V <sub>gs</sub> =0V	1.65	1.8	2.0	V
Dynamic Parameters		Test data					
	Parameters		Conditions	Min	Typical	Max	Unit
	C <sub>iss</sub>	Input capacitance	V <sub>gs</sub> =0V		90		pf
1	Coss	Output capacitance	V <sub>ds</sub> =400V		25		pf
	C <sub>rss</sub>	Reverse transfer capacitance	f=1MHz		0.9		pf
	Qg	Gate charge	V <sub>ds</sub> =400V		2.6		nC
3	Q <sub>gs</sub>	Gate to source charge	I <sub>d</sub> =9A		0.5		nC
	Q <sub>gd</sub>	Gate to drain charge	V <sub>gs</sub> =6V		0.65		nC
2	Q <sub>rr</sub>	Reverse recovery charge			0		nC
Switching Performance			Test data				
	Parameters		Conditions	Min	Typical	Max	Unit
1	t <sub>d(on)</sub>	Turn-on delay time	V <sub>ds</sub> =400V		5		ns
2	t <sub>r</sub>	Rise time	I <sub>d</sub> =2.5A		10		ns
3	t <sub>d(off)</sub>	Turn-off delay time	$R_g=10\Omega$		16		ns
3	•u(011)						



### Absolute Max. Ratings

	Symbols Parameters		Value	Unit
1	V <sub>DS-max</sub> Breakdown voltage transient @ T <sub>case</sub> =25°C		800	٧
2	V <sub>GS-max</sub> Gate to source max. transient voltage @ T <sub>case</sub> =25°C		-12 to +7.5	V
3	I <sub>ds-max</sub>	Drain to source DC current @ T <sub>case</sub> =25°C	10	А
4	I <sub>ds-max</sub>	Drain to source DC current @ T <sub>case</sub> =100°C	8	А
5	dv/dt <sub>-max</sub>	Drain to source voltage slew rate	200	V/nS
6	T <sub>J-max</sub>	Max junction temperature	150	°C
7	$T_{S-storage}$	Storage temperature	-55 to 150	°C

## **Thermal and Soldering Characteristics (Typical)**

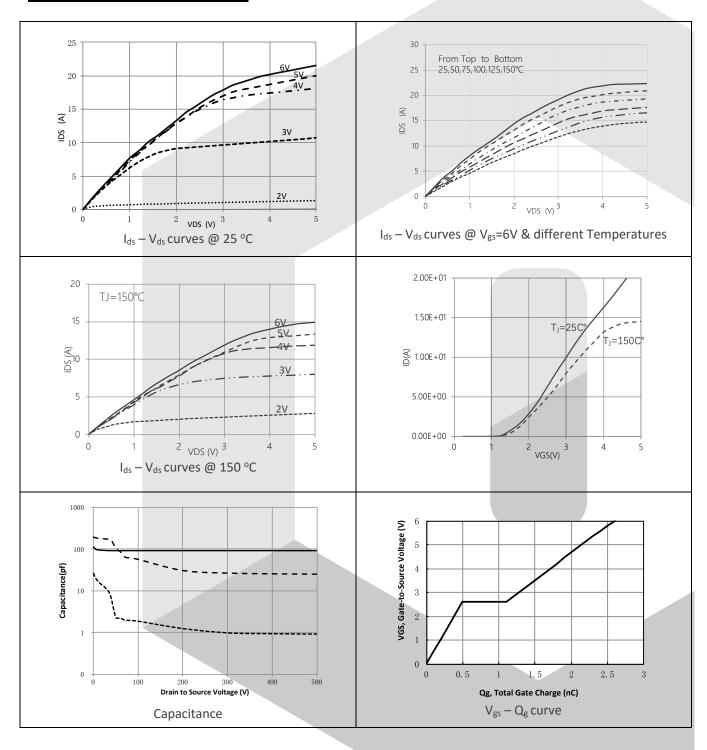
	Symbols	Parameters	Value	Unit
1	$R_{thJC}$	Thermal resistance (junction to case)	0.7	°C /W
2	$T_{solder}$	Reflow soldering temperature	250	°C

### **Ordering**

Order Code	Package Type	Packaging Method	Qty
GPI65010DF88	DFN surface mount, bottom cooled, 8X8 mm	Tape and Reel	3500



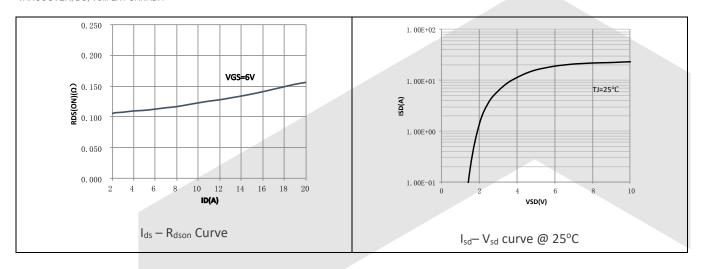
#### **Electrical Performance**



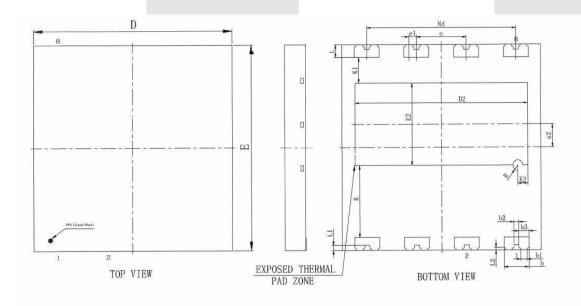


#### GaNPower International Inc.

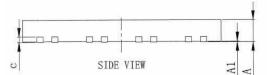
WWW. IGANPOWER.COM 230 -3410 LOUGHEED HWY VANCOUVER, BC, V5M 2A4 CANADA



# Package Information



est (pot	MILLIMETER		
SYMBOL	MIN	NOM	MAX
Λ	0.80	0.85	0. 90
A1	0	0. 02	0.05
b	0.95	1.00	1.05
b1		). 25REF	
b2		o. 20REF	
b3	0.35	0.40	0.45
c	. (	). 203REF	15
D	7.90	8.00	8, 10
D2	6.84	6. 94	7. 04
Nd	6. 00BSC		
е	2. 00BSC		
e1	0. 30BSC		
e2		0. 90BSC	
E	7. 90	8. 00	8. 10
E2	3. 10	3. 20	3. 30
L	0.45	0.50	0, 55
L1	0. 20REF		
L2	0. 10REF		
K	2. 80REF		
K1	1. OOREF		
K2		0. 40RE	F .
R	0. 15	0. 20	0.25





## **GaN HEMT Frequently Asked Questions**

Q: Can we do pin to pin switch for silicon MOSFET or IGBT?  A: The short answer is no. GaN HEMT power devices are far superior than the best silicon devices such as super junction MOSFETs. However, due to different requirements of gate driving voltage and extremely high dv/dt slew rate, special drivers and optimized PCB layouts are recommended to minimize the impact from circuit parasitics. Some packaging forms such as GaNPower's DFN packaged devices offer both sense and force for the source terminal. Also, for traditional TO220 packages, please be advised that the pins are arranged as Gate – Source -Drain, and the thermal pad is connected to the source instead of drain.
Q: Are GaN power devices reliable? A: GaN power HEMTs have been tested by GaNPower and many other vendors, users and testing facilities to be as reliable (if not better than) silicon counterparts.
Q: How do GaN power devices compare with SiC?  A: Currently GaN power HEMT devices are most suitable for low to medium voltage (≤1200V) and power (<20KW) applications. GaN is the ideal choice for high frequency applications. SiC devices are better choice for high voltage and high-power applications (>20KW).
Q: Do we need to parallel an FRD for applications such as inverters?  A: GaN devices are different from silicon MOSFET or IGBT in that they have no inherent PN junction diodes that cause reverse recovery issue. User do not need to parallel an FRD for the purpose of suppressing the body diode reverse recovery effect, since GaN HEMT can operate in both first and third quadrants. However, care should be taken for the dead time power loss since the Vsd voltage of GaN HEMT is usually close to 2V. This is especially true when a negative gate voltage is applied.
Q: Can we parallel GaN HEMT devices?  A: Yes, GaN HEMT is ideal for paralleling, due to positive temperature coefficient of Rdson and slightly positive temperature coefficient of threshold voltage.
Q: Where can we find drivers for GaNPower HEMT devices?  A: While some of the GaNPower's HEMTs are either monolithically integrated with gate driver or co-packaged with a silicon driver, drivers can be easily found from vendors such as TI and Silicon Lab for either single sided or half-bridge configurations:  ✓ TI: LM5114: Single 7.6A Peak Current Low-Side Gate Driver  ✓ TI: UCC27611: 5V, 4A/6A Low Side GaN Driver  ✓ Maxim: MAX5048C: 7A Sink/3A Source Current, 8ns, SOT23, MOSFET Drive  ✓ Fairchild: FAN3122: Single 9-A High-Speed, Low-Side Gate Driver  ✓ Silicon Lab: Si827X: 4 Amp ISO driver with High Transient (dv/dt) Immunity